

**Customer:** 

Representative:

Type: A9013

PerkinElmer Part No.: 95503651

Date: 2005.11.30

This specification has been provided by R &D Department of PerkinElmer Optoelectronics

No. of Samples: NA

Technical Data: 4 pages

The undersigned hereby confirm that PerkinElmer quality assurance system has been applied to the shipment this specification is attached to. All devices have met the requirements of PerkinElmer test specifications and passed a 100% final production test plus a sample lot outgoing inspection in accordance with GB/T 2828.1-2003/ISO 2859-1: 1999.

CHECKED:	APPROVED : William Wang 2005.11.30

<u>Customer Approval:</u> Date Signature

IN CASE OF SAMPLES ACCEPTANCE ; PLEASE ATTACH THE SIGNED FRONT PAGE OF THIS SPECIFICATION TO YOUR KIND ORDER



	Type:	A9013	
X Standard Type		Customer Specific Type	

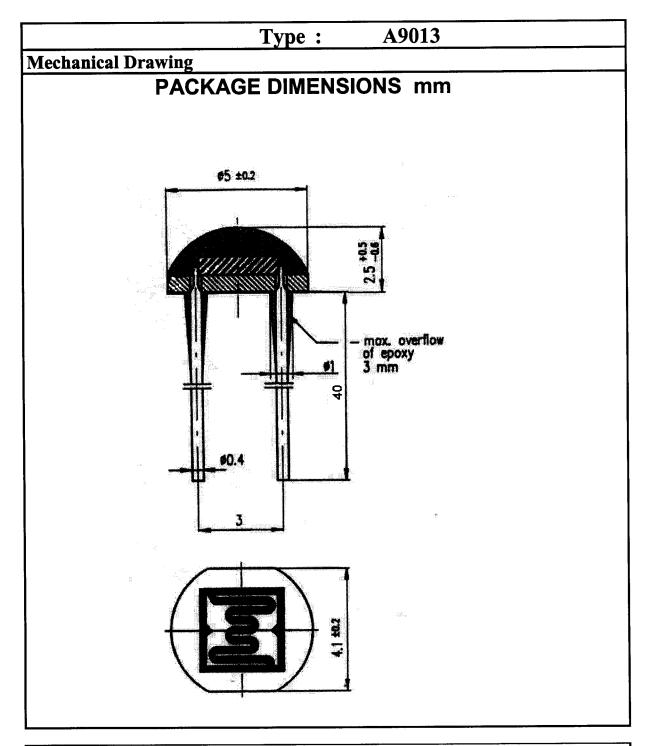
The marked test criteria have been applied to the attached samples and will be implemented as 100% test at final assembly. Below typical characteristic data are provided for reference.

	R	1	Resistance value at 1 lux (0.093 fc)	:		kΩ
x	R	10	Resistance value at 10 lux (0.93 fc)	:	27 – 94	kΩ
	R	100	Resistance value at 100 lux (9.3 fc)	:		kΩ
	R	40	Resistance value as stated besides	:		kΩ
x	$R_0$	1	Minimum Resistance 1 sec after removal from light	:	0.5	ΜΩ
	$R_0$	5	Minimum Resistance 5 sec after removal from light	:		ΜΩ
	$R_0$		Minimum Resistance after dark time stated besides	:		ΜΩ
	γ		Slope as given by $\frac{\lg(R10/R100)}{\lg(100/10)}$ typ.	:		

LIMIT VALUES			
Maximum Power Dissipation	:	90	mW
Maximum Supply Voltage (DC or AC <sub>pk</sub> )	:	150	V
Temperature Coefficient	:	0.4	%/°C
Peak Spectral Response	:	600±20	nm

ENC	APSULATION			
	Hermetically Sealed Metal Case			
	Hermetically Sealed Glass Bulb			
x	<b>Epoxy Coating</b>			
	Lacquer Coating			
	Date 2005.11.30	Signature William Wang		





Date 2005.11.29

Signature William Wang



#### COMMON INFORMATIONS

PerkinElmer Photoconductive Cells pass a 100% final electrical test, consisting light readings at defined light level(s) and dark resistance  $R_0$  taken at certain sec after switch off of an illumination as specified. Additionally an outgoing test according to GB/T 2828.1-2003/ISO 2859-1: 1999 is applied to all shipments. Prior to measurements, all devices are exposed to normal room light (approx. 500 lux) for at least 16 hours. This preconditioning compensates the effect of "light history", a typical reaction of this kind of semiconductive component, leading usually to an adaption of resistance value to its preillumination within a certain range. If no special procedure is required , all readings are taken under a tungsten filament light source being run at  $2854 \pm 50$  K color temperature. Dark resistance readings are achieved at the defined time after covering the light source with an electromagnetic shutter within 10 msec.

#### LONG TIME STABILITY

is influenced by light history effect as well. Stability of light readings will be guaranteed in case of approximately equal intervals of bright and dark ambient conditions. In case of application of only singular light condition an increase of typical readings has to be expected in case of high ambient light, a decrease in case of long dark period. The absolute variation will be within  $\pm$  10% at 10 lux with tendencily higher deviation at lower light levels.

#### STORAGE AND HANDLING

All PerkinElmer photoconductive cells are subjected to an artificial aging cycle consisting various combinations of illumination and temperature for a certain time. This aging guarantees constancy of light reaings at ambient temperatures up to 70°C within the announced temperature coefficient range. Recommended storage conditions are temperatures beneath 60°C and usual moisture of approximately 50% r.H. Through soldering process a preheating of components surface exceeding 130°C should be avoided. Automatic soldering shouldn't last more than 10 seconds at 260°C. Otherwise a stand off of 5 mm should be applied.